





TDP2004

TDP2004 4 チャネル 20Gbps DisplayPort 2.1 リニア リドライバ

1 特長

- 最大 20Gbps の DisplayPort 2.1 をサポート RBR、 HBRx, UHBRx
- 最大 20Gbps までのほとんどの AC 結合インターフェ イスをサポートする、プロトコルに依存しないリニアイコ ライザ
- 20Gbps (10Ghz ナイキスト) での優れた電気的性能:
 - 19dB のイコライゼーション
 - 1.8V DC の直線性、1.08V AC の直線性
 - -15/-16dB Rx/Tx リターン ロス
 - -60dB の NEXT、-43dB の FEXT クロストーク
 - PRBS データによる 70fs の低付加 RJ
- DisplayPort 1.4 および 2.1 リンクトレーニングに対し て透過的
- 3.3V 単一電源、低アクティブ電力:160mW/チャネル
- 内部電圧レギュレータにより電源ノイズへの耐性を実
- 高い直線性により DP コンプライアンス テストが容易
- 高いチャネル BW による優れたリニア EQ カーブ
- - 18 個の EQ ブースト設定
 - 5個のフラットゲイン設定
- TDP2004:0°C~70°Cの商業用温度範囲
- TDP2004I:-40℃~85℃の産業用温度範囲
- 4mm × 6mm、40 ピン WQFN パッケージ

2 アプリケーション

- デスクトップ PC またはマザーボード
- PC、ノートPC、およびタブレット
- ドッキング・ステーション
- TV、ゲーム、ホームシアター、およびエンターテインメ
- 業務用オーディオ、ビデオ、サイネージ
- 試験/測定機器
- 医療用
- フラット パネル モニタ

3 概要

TDP2004 は、4 チャネルの低消費電力高性能リニア リピ ータまたはリドライバで、最大 20Gbps の DisplayPort 2.1 をサポートするよう設計されています。

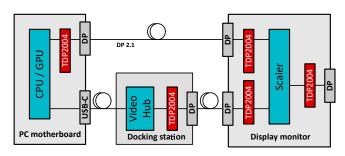
TDP2004 のレシーバは、連続時間リニア イコライザ (CTLE)を搭載し、プログラマブルな高周波数での昇圧を 実現しています。イコライザは、相互接続媒体 (例:PCB 配線) に起因する符号間干渉 (ISI) によって完全に閉じた 入力アイ パターンを開くことができます。 CTLE レシーバ にはリニア出力ドライバが接続されています。TDP2004 のリニアなデータパスは、送信プリセット信号特性を保持し ます。高帯域幅で、チャネル間クロストークが少なく、付加 ジッタが小さく、反射損失特性が非常に優れた本デバイス は、便利なイコライゼーション機能を備えていることを除い て、リンク内でほとんど受動素子のように振舞います。 DisplayPort リンクのトレーニングは、ソース Tx とシンク Rx の間でパッシブ チャネルの一部となるリニア リドライバ を使用して効果的に行われます。このリンクトレーニング プロトコルの透過性は、最適な電気的リンクと最短のレイテ ンシをもたらします。本デバイスのデータパスは、基板上 のすべての電源ノイズに対して高い耐性を示す内部的に 安定化された電源レールを使用しています。

また、このデバイスは AC および DC ゲインの変動が小さ いため、大容量プラットフォームを展開する際の一貫した イコライゼーションにも対応しています。

パッケージ情報

部品番号	パッケージ ⁽¹⁾	パッケージ サイズ ⁽²⁾
TDP2004	RNQ (WQFN, 40)	4mm × 6mm

- 詳細については、セクション 10 を参照してください。
- パッケージ サイズ (長さ×幅) は公称値であり、該当する場合はピ ンも含まれます。



代表的なアプリケーション



Table of Contents

1 特長	1	6.3 Feature Description	11
2 アプリケーション		6.4 Device Functional Modes	
3 概要		6.5 Programming	13
4 Pin Configuration and Functions		7 Application and Implementation	17
5 Specifications		7.1 Application Information	17
5.1 Absolute Maximum Ratings		7.2 Typical Applications	17
5.2 ESD Ratings		7.3 Power Supply Recommendations	19
5.3 Recommended Operating Conditions		7.4 Layout	<mark>20</mark>
5.4 Thermal Information.		8 Device and Documentation Support	<mark>21</mark>
5.5 DC Electrical Characteristics		8.1ドキュメントの更新通知を受け取る方法	21
5.6 High Speed Electrical Characteristics	8	8.2 サポート・リソース	21
5.7 SMBUS/I ² C Timing Characteristics		8.3 Trademarks	21
5.8 Typical Characteristics		8.4 静電気放電に関する注意事項	21
5.9 Typical Jitter Characteristics		8.5 用語集	
6 Detailed Description		9 Revision History	
6.1 Overview		10 Mechanical, Packaging, and Orderable	
6.2 Functional Block Diagram		Information	21
-			

Product Folder Links: TDP2004

4 Pin Configuration and Functions

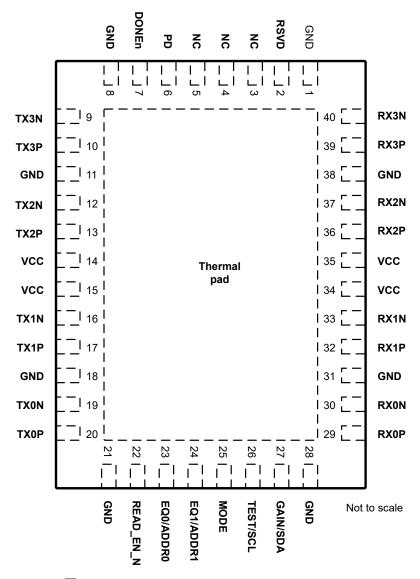


図 4-1. RNQ Package, 40-Pin WQFN (Top View)

表 4-1. Pin Functions

NAME NO.		TYPE(1)	DESCRIPTION
		IIPE\/	DESCRIPTION
DONEn	7	O, 3.3V open drain	In SMBus/I ² C Primary mode: Indicates the completion of a valid EEPROM register load operation. External pullup resistor such as 4.7kΩ required for operation. High: External EEPROM load failed or incomplete Low: External EEPROM load successful and complete In SMBus/I ² C Secondary/Pin mode: This output is High-Z. The pin can be left floating.



表 4-1. Pin Functions (続き)

PI	N		表 4-1. Pin Functions (続き)			
NAME	NO.	TYPE ⁽¹⁾	DESCRIPTION			
MODE	25	I, 5-level	Sets device control configuration modes. 5-level IO pin as provided in 表 6-3. The pin can be exercised at device power up or in normal operation mode. L0: Pin mode – device control configuration is done solely by strap pins. L1: SMBus/I²C Primary mode – device control configuration is read from external EEPROM. When the TDP2004 finishes reading from the EEPROM successfully, DONEn pin is pulled LOW. SMBus/I²C secondary operation is available in this mode before, during or after EEPROM reading. Note: during EEPROM reading if the external SMBus/I²C primary wants to access TDP2004 registers, the external controller must support arbitration. L2: SMBus/I²C Secondary mode – device control configuration is done by an external controller with SMBus/I²C primary. L3 and L4 (Float): RESERVED – TI internal test modes.			
EQ0 / ADDR0	23	I, 5-level	In Pin mode:			
EQ1 / ADDR1	24	I, 5-level	Sets receiver linear equalization (CTLE) boost for channels 0-3 as provided in 表 6-1. These pins are sampled at device power up only. In SMBus/I²C mode: Sets SMBus / I²C secondary address as provided in 表 6-4. These pins are sampled at device power up only.			
GAIN / SDA	27	I, 5-level / I/O, 3.3V LVCMOS, open drain	In Pin mode: Flat gain (DC and AC) from the input to the output of the device for channels 0-3. The pin is sampled at device power up only. In SMBus/I²C mode: 3.3V SMBus/I²C data. External $1k\Omega$ to $5k\Omega$ pullup resistor is required as per SMBus / I^2 C interface standard.			
GND	1, 8, 11, 18, 21, 28, 31, 38, EP	Р	Ground reference for the device. EP: the Exposed Pad at the bottom of the QFN package, which is used as the GND return for the device. The EP must be connected to one or more ground planes through the low resistance path. A via array provides a low impedance path to GND. The EP also improves thermal dissipation.			
PD	6	I, 3.3V LVCMOS	2-level logic controlling the operating state of the redriver. Active in all device control modes. The pin has internal 1M Ω weak pulldown resistor. High: power down for channels 0-3 Low: power up, normal operation for channels 0-3			
READ_EN_N	22	I, 3.3V LVCMOS	In SMBus/I²C Primary mode: After power up, when the pin is low, the device initiates the SMBus / I²C Primary mode EEPROM read function. When EEPROM read is complete (indicated by assertion of DONEn low), this pin can be held low for normal device operation. During the EEPROM load process the signal path of the device is disabled. In SMBus/I²C Secondary and Pin modes: In these modes the pin is not used. The pin can be left floating. The pin has internal $1M\Omega$ weak pulldown resistor.			
RSVD	2	_	Reserved use for TI. The pin must be left floating (NC).			
TEST / SCL	26	I, 5-level / I/O, 3.3V LVCMOS, open drain	In Pin mode: TI test mode. External $1k\Omega$ pulldown resistor must be installed. In SMBus/I²C mode: 3.3V SMBus/I²C clock. External $1k\Omega$ to $5k\Omega$ pullup resistor is required as per SMBus / $I²C$ interface standard.			
RX0N	30	I	Inverting differential inputs to the equalizer. Integrated 50Ω termination resistor from the pin to internal CM bias voltage. Channel 0.			
RX0P	29	I	Noninverting differential inputs to the equalizer. Integrated 50Ω termination resistor from the pin to internal CM bias voltage. Channel 0.			
RX1N	33	I	Inverting differential inputs to the equalizer. Integrated 50Ω termination resistor from the pin to internal CM bias voltage. Channel 1.			
RX1P	32	I	Noninverting differential inputs to the equalizer. Integrated 50Ω termination resistor from the pin to internal CM bias voltage. Channel 1.			
RX2N	37	I	Inverting differential inputs to the equalizer. Integrated 50Ω termination resistor from the pin to internal CM bias voltage. Channel 2.			

Copyright © 2024 Texas Instruments Incorporated

1

Product Folder Links: TDP2004

表 4-1. Pin Functions (続き)

PII	N	TYPE ⁽¹⁾	DESCRIPTION
NAME NO.		ITPE(''	DESCRIPTION
RX2P	36	I	Noninverting differential inputs to the equalizer. Integrated 50Ω termination resistor from the pin to internal CM bias voltage. Channel 2.
RX3N	40	I	Inverting differential inputs to the equalizer. Integrated 50Ω termination resistor from the pin to internal CM bias voltage. Channel 3.
RX3P	39	I	Noninverting differential inputs to the equalizer. Integrated 50Ω termination resistor from the pin to internal CM bias voltage. Channel 3.
TX0N	19	0	Inverting pin for 100Ω differential driver output. Channel 0.
TX0P	20	0	Noninverting pin for 100Ω differential driver output. Channel 0.
TX1N	16	0	Inverting pin for 100Ω differential driver output. Channel 1.
TX1P	17	0	Noninverting pin for 100Ω differential driver output. Channel 1.
TX2N	12	0	Inverting pin for 100Ω differential driver output. Channel 2.
TX2P	13	0	Noninverting pin for 100Ω differential driver output. Channel 2.
TX3N	9	0	Inverting pin for 100Ω differential driver output. Channel 3.
TX3P	10	0	Noninverting pin for 100Ω differential driver output. Channel 3.
VCC	14, 15, 34, 35	Р	Power supply pins. VCC = 3.3V ±10%. The VCC pins on this device must be connected through a low-resistance path to the board VCC plane. Install a decoupling capacitor to GND near each VCC pin.

⁽¹⁾ I = input, O = output, P = power

5

Product Folder Links: TDP2004



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
VCC _{ABSMAX}	Supply voltage (VCC)	-0.5	4.0	V
VIO _{CMOS,ABSMAX}	3.3V LVCMOS and open drain I/O voltage	-0.5	4.0	V
VIO _{5LVL,ABSMAX}	5-level input I/O voltage	-0.5	2.75	V
VIO _{HS-RX,ABSMAX}	High-speed I/O voltage (RXnP, RXnN)	-0.5	3.2	V
VIO _{HS-TX,ABSMAX}	High-speed I/O voltage (TXnP, TXnN)	-0.5	2.75	V
T _{J,ABSMAX}	Junction temperature		150	°C
T _{stg}	Storage temperature range	-65	150	°C

⁽¹⁾ Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

5.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
V _(ESD)	Liectiostatic discharge	Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±500	

JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±2kV may actually have higher performance.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
VCC	Supply voltage, VCC to GND	DC plus AC power must not exceed these limits	3.0	3.3	3.6	V
		DC to <50Hz, sinusoidal			250	mVpp
		50Hz to 500kHz, sinusoidal			100	mVpp
N _{VCC} (1)	Supply noise tolerance	500kHz to 2.5MHz, sinusoidal			33	mVpp
		Supply noise, >2.5MHz, sinusoidal			10	mVpp
T _{RampVCC}	VCC supply ramp time	From 0V to 3.0V	0.150		100	ms
т.	Operating ambient temperature	TDP2004	0		70	°C
'A		TDP2004I	-40		85	°C
т.	Operating junction temperature	TDP2004			105	°C
T _A		TDP2004I			125	°C
PW _{LVCMOS}	Minimum pulse width required for the device to detect a valid signal on LVCMOS inputs	PD and READ_EN_N	200			μs
VCC _{SMBUS}	SMBus/I ² C SDA and SCL opendrain termination voltage	Supply voltage for open-drain pullup resistor			3.6	V
F _{SMBus}	SMBus/I ² C clock (SCL) frequency	SMBus secondary mode	10		400	kHz
VID _{LAUNCH}	Source launch amplitude	Differential signaling			1200	mVpp

Product Folder Links: TDP2004

Copyright © 2024 Texas Instruments Incorporated

⁽²⁾ JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
DR	Data rate	1		20	Gbps

⁽¹⁾ Sinusoidal noise is superimposed to supply voltage with negligeable impact to device function or critical performance shown in the Electrical Table. Steps must be taken to ensure the combined AC plus DC supply noise meets the specified VDD supply voltage limits.

5.4 Thermal Information

		TDP2004	
	THERMAL METRIC ⁽¹⁾	RNQ, 40 Pins	UNIT
R _{θJA-High K}	Junction-to-ambient thermal resistance	30.7	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	20.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	11.4	°C/W
ΨЈТ	Junction-to-top characterization parameter	0.3	°C/W
ΨЈВ	Junction-to-board characterization parameter	11.4	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	3.8	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report.

5.5 DC Electrical Characteristics

over operating free-air temperature and voltage range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power					•	
П	Daving active newer	4 channels active, EQ = 0-2		0.57	0.71	W
P _{ACT}	Device active power	4 channels active, EQ = 5-19		0.69	0.85	W
P _{STBY}	Device power consumption in standby power mode	All channels disabled (PD = H)		17	25	mW
Control IO						
V _{IH}	High level input voltage	SDA, SCL, PD, READ_EN_N pins	2.1			V
V _{IL}	Low level input voltage	SDA, SCL, PD, READ_EN_N pins			1.08	V
V _{OH}	High level output voltage	$R_{pullup} = 4.7k\Omega$ (SDA, SCL, DONEn pins)	2.1			V
V _{OL}	Low level output voltage	I _{OL} = -4mA (SDA, SCL, DONEn pins)			0.4	V
I _{IH}	Input high leakage current	V _{Input} = VCC, (SCL, SDA, PD, READ_EN_N pins)			10	μΑ
I _{IL}	Input low leakage current	V _{Input} = 0V, (SCL, SDA, PD, READ_EN_N pins)	-10			μA
I _{IH,FS}	Input high leakage current for fail safe input pins	V _{Input} = 3.6V, VCC = 0V, (SCL, SDA, PD, READ_EN_N pins)			200	μA
C _{IN-CTRL}	Input capacitance	SDA, SCL, PD, READ_EN_N pins		1.6		pF
5 Level IOs	(MODE, GAIN, EQ0, EQ1 pins)					
I _{IH_5L}	Input high leakage current, 5-level IOs	VIN = 2.5V			10	μA
I _{IL_5L}	Input low leakage current for all 5-level IOs except MODE.	VIN = GND	-10			μΑ
I _{IL_5L,MODE}	Input low leakage current for MODE pin	VIN = GND	-200			μΑ
Receiver						
V _{RX-DC-CM}	RX DC common vode voltage	Device is in active or standby state		1.4		V
Z _{RX-DC}	Rx DC single-ended impedance			50		Ω
Transmitter						

Product Folder Links: TDP2004

資料に関するフィードバック(ご意見やお問い合わせ)を送信

English Data Sheet: SNLS745



over operating free-air temperature and voltage range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Z _{TX-DIFF-DC}	DC differential Tx impedance	Impedance of Tx during active signaling, VID,diff = 1Vpp		100		Ω
V _{TX-DC-CM}	Tx DC common mode voltage			1.0		V
I _{TX-SHORT}	Tx short circuit current	Total current the Tx can supply when shorted to GND		70		mA

5.6 High Speed Electrical Characteristics

over operating free-air temperature and voltage range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN TYP	MAX	UNIT
Receiver					
		3GHz	-19		dB
		4GHz	-18		dB
RL _{RX-DIFF}	Input differential return loss	5GHz	-18		dB
		6GHz	-17		dB
		10GHz	-15		dB
XT _{RX}	Receiver-side pair-to-pair isolation; Port A or Port B	Minimum over 10MHz to 10GHz range	-60		dB
Transmitter					
RL _{TX-DIFF}	Output differential return loss	3GHz	-19		dB
RL _{TX-DIFF}	Output differential return loss	4.0GHz	-18		dB
RL _{TX-DIFF}	Output differential return loss	5.0GHz	-18		dB
RL _{TX-DIFF}	Output differential return loss	6.0GHz	-17		dB
RL _{TX-DIFF}	Output differential return loss	10GHz	-16		dB
XT _{TX}	Transmit-side pair-to-pair isolation	Minimum over 10MHz to 10GHz range -60			dB
Device Datap	path				
T _{PLHD/PHLD}	Input-to-output latency (propagation delay) through a data channel	For either low-to-high or high-to-low transition.	100	130	ps
L _{TX-SKEW}	Lane-to-lane output skew	Between any two lanes within a single transmitter.		20	ps
T _{RJ-DATA}	Additive random jitter with data	Jitter through redriver minus the calibration trace. 20Gbps PRBS15. 800mVpp-diff input swing	70		fs
XT	Channel to channel xtalk (between adjacent active channels, FEXT	Minimum over 10MHz to 10Ghz range, normalized to EQ gain of 0dB	-43		dB
		Minimum EQ, GAIN = L0	-5.6		dB
		Minimum EQ, GAIN = L1	-3.8		dB
FLAT-GAIN	Broadband DC and AC flat gain - input to output, measured at DC	Minimum EQ, GAIN = L2	-1.2		dB
	to surpar, measured at 20	Minimum EQ, GAIN = L3	2.6		dB
		Minimum EQ, GAIN = L4 (Float)	0.6		dB
EQ-MAX _{10G}	EQ boost at max setting (EQ INDEX = 19)	AC gain at 10GHz relative to gain at 100MHz.			dB
LINEARITY- DC	Output DC linearity	at GAIN = L4	1750		mVpp
LINEARITY-	Output AC linearity	at 10Gbps, with GAIN = L4	1100		mVpp
AC	Output AC linearity	at 20Gbps, with GAIN = L4	1080		mVpp

Product Folder Links: TDP2004

資料に関するフィードバック(ご意見やお問い合わせ)を送信

Copyright © 2024 Texas Instruments Incorporated

8

English Data Sheet: SNLS745

5.7 SMBUS/I²C Timing Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Secondary	Mode				<u> </u>	
t _{SP}	Pulse width of spikes which must be suppressed by the input filter				50	ns
t _{HD-STA}	Hold time (repeated) START condition. After this period, the first clock pulse is generated		0.6			μs
t _{LOW}	LOW period of the SCL clock		1.3			μs
T _{HIGH}	HIGH period of the SCL clock		0.6			μs
t _{SU-STA}	Setup time for a repeated START condition		0.6			μs
t _{HD-DAT}	Data hold time		0			μs
T _{SU-DAT}	Data setup time		0.1			μs
t _r	Rise time of both SDA and SCL signals	Pullup resistor = 4.7kΩ, Cb = 10pF		120		ns
t _f	Fall time of both SDA and SCL signals	Pullup resistor = 4.7kΩ, Cb = 10pF		2		ns
t _{SU-STO}	Setup time for STOP condition		0.6			μs
t _{BUF}	Bus free time between a STOP and START condition		1.3			μs
t _{VD-DAT}	Data valid time				0.9	μs
t _{VD-ACK}	Data valid acknowledge time				0.9	μs
C _b	Capacitive load for each bus line				400	pF
Primary Mo	de					
f _{SCL-M}	SCL clock frequency			303		kHz
t _{LOW-M}	SCL low period			1.90		μs
T _{HIGH-M}	SCL high period			1.40		μs
t _{SU-STA-M}	Setup time for a repeated START condition			2		μs
t _{HD-STA-M}	Hold time (repeated) START condition. After this period, the first clock pulse is generated			1.5		μs
T _{SU-DAT-M}	Data setup time			1.4		μs
t _{HD-DAT-M}	Data hold time			0.5		μs
t _{R-M}	Rise time of both SDA and SCL signals	Pullup resistor = 4.7kΩ, Cb = 10pF		120		ns
T _{F-M}	Fall time of both SDA and SCL signals	Pullup resistor = 4.7kΩ, Cb = 10pF		2		ns
t _{su-sто-м}	Stop condition setup time			1.5		μs
EEPROM T	iming					
T _{EEPROM}	EEPROM configuration load time	Time to assert DONEn after READ_EN_N has been asserted.		7.5		ms
T _{POR}	Time to first SMBus access	Power supply stable after initial ramp. Includes initial power-on reset time.	,	50		ms

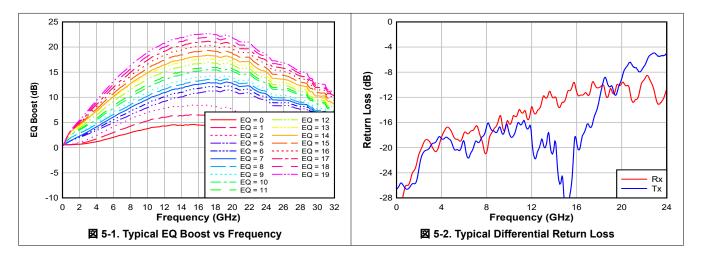
9

Product Folder Links: TDP2004



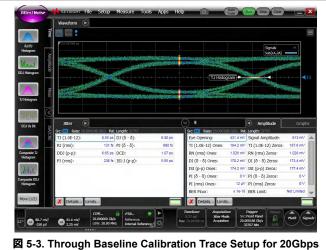
5.8 Typical Characteristics

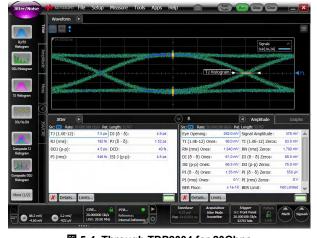
🗵 5-1 shows typical EQ gain curves versus frequency for different EQ settings. 🗵 5-2 shows typical differential return loss for Rx and Tx pins.



5.9 Typical Jitter Characteristics

🗵 5-3 and 🗵 5-4 show eye diagrams at 20Gbps that compare jitter through calibration traces (left), and jitter through TDP2004 (right) at TI evaluation boards with minimal channels. The eye diagrams illustrate that TDP2004 adds very little random jitter (RJ).





6 Detailed Description

6.1 Overview

The TDP2004 is a four-channel multi-rate linear repeater with integrated signal conditioning. The signal channels of the device operate independently from one another. Each channel includes a continuous-time linear equalizer (CTLE) and a linear output driver, which together compensate for a lossy transmission channel between the source transmitter and the final receiver. The linearity of the data path is specifically designed to preserve any transmit equalization while keeping receiver equalization effective.

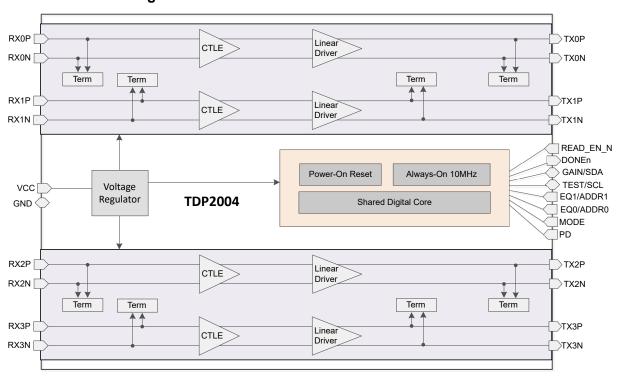
The TDP2004 can be configured three different ways:

Pin mode – device control configuration is done solely by strap pins. Pin mode is expected to be satisfactory `for many system implementation needs.

SMBus/I²C Primary mode – device control configuration is read from external EEPROM. When the TDP2004 has finished reading from the EEPROM successfully, the device drives the DONEn pin LOW. SMBus/I²C secondary operation is available in this mode before, during, or after EEPROM reading. Note: during EEPROM reading, if the external SMBus/I²C primary wants to access TDP2004 registers, the external controller must support arbitration. The mode is preferred when software implementation is not desired.

SMBus/I²C Secondary mode – provides most flexibility. Requires a SMBus/I²C primary device to configure TDP2004 though writing to the secondary address.

6.2 Functional Block Diagram



6.3 Feature Description

6.3.1 Linear Equalization

The TDP2004 receivers feature a continuous-time linear equalizer (CTLE) that applies high-frequency boost and low-frequency attenuation to help equalize the frequency-dependent insertion loss effects of the passive channel. The receivers implement two stage linear equalizer for wide range of equalization capability. The equalizer stages also provide flexibility to make subtle modifications of mid-frequency boost for best EQ gain profile match with wide range of channel media characteristics. The EQ profile control feature is only available in SMBus/I²C mode. In Pin mode the settings are optimized for FR4 traces.

Copyright © 2024 Texas Instruments Incorporated

資料に関するフィードバック(ご意見やお問い合わせ) を送信

11



表 6-1 provides available equalization boost at 20Gbps (10GHz Nyquist frequency) through EQ control pins or SMBus/I²C registers. In Pin Control mode EQ1 and EQ0 pins set equalization boost for channels 0-3. In I²C mode individual channels can be independently programmed for EQ boost. If the TDP2004 is used for other data rates equalization gain can be extracted from ⋈ 5-1.

表 6-1. Equalization Control Settings

	EQUALIZATION SETTING							
	Pin n	node		SMBus/I	² C Mode			
EQ INDEX	EQ1	EQ0	eq_stage1_3:0	eq_stage2_2:0	eq_profile_3:0	eq_stage1_bypass	at 10GHz	
0	L0	L0	0	0	0	1	4.0	
1	L0	L1	1	0	0	1	5.0	
2	L0	L2	3	0	0	1	7.0	
5	L1	L0	0	0	1	0	8.0	
6	L1	L1	1	0	1	0	9.0	
7	L1	L2	2	0	1	0	9.5	
8	L1	L3	3	0	3	0	10.0	
9	L1	L4	4	0	3	0	11.0	
10	L2	L0	5	1	7	0	12.0	
11	L2	L1	6	1	7	0	12.5	
12	L2	L2	8	1	7	0	13.5	
13	L2	L3	10	1	7	0	14.5	
14	L2	L4	10	2	15	0	15.0	
15	L3	L0	11	3	15	0	15.5	
16	L3	L1	12	4	15	0	16.5	
17	L3	L2	13	5	15	0	17.0	
18	L3	L3	14	6	15	0	18.0	
19	L3	L4	15	7	15	0	19.0	

6.3.2 Flat-Gain

The GAIN pin can be used to set the overall data-path flat gain (DC and AC) of the TDP2004 when the device is in Pin mode. The pin GAIN sets the Flat-Gain for channels 0-3. In I^2C mode each channel can be independently set. $\frac{1}{2}$ 6-2 provides flat gain control configuration settings. For most systems the default setting of GAIN = L4 (float) is recommended that provides flat gain of 0dB.

The flat-gain and equalization of the TDP2004 must be set such that the output signal swing at DC and high frequency does not exceed the DC and AC linearity ranges of the devices, respectively.

表 6-2. Flat Gain Configuration Settings

Pin mode GAIN	I ² C Modeflat_gain_2:0	Flat Gain
L0	0	-5.6dB
L1	1	-3.8dB
L2	3	-1.2dB
L4 (float)	5	0.6dB (default recommendation)
L3	7	+2.6dB

資料に関するフィードバック(ご意見やお問い合わせ) を送信

Copyright © 2024 Texas Instruments Incorporated

6.4 Device Functional Modes

6.4.1 Active Mode

The device is in normal operation. In this mode, the TDP2004 redrives and equalizes video mainlink signals to provide better signal integrity.

6.4.2 Standby Mode

The device is in standby mode invoked by PD = H. In this mode, the device is in standby mode conserving power.

6.5 Programming

6.5.1 Pin mode

The TDP2004 can be fully configured through pin-strap pins. In this mode the device uses 2-level and 5-level pins for device control and signal integrity optimum settings.

6.5.1.1 Five-Level Control Inputs

The TDP2004 has four (EQ0, EQ1, GAIN, and MODE) 5-level input pins that are used to control the configuration of the device. These 5-level inputs use a resistor divider to help set the 5 valid levels and provide a wider range of control settings. External resistors must be of 10% tolerance or better. The 5-level pins except MODE are sampled at powerup only. The MODE pin can be exercised at device power up or in normal operation mode.

LEVEL SETTING L0 $1k\Omega$ to GND L1 $8.25k\Omega$ to GND L2 $24.9k\Omega$ to GND L3 $75k\Omega$ to GND L4 F (Float)

表 6-3. 5-Level Control Pin Settings

6.5.2 SMBUS/I²C Register Control Interface

If MODE = L2 (SMBus/ I^2 C Secondary control mode), then the TDP2004 is configured through a standard I^2 C or SMBus interface that can operate up to 400kHz. The secondary address of the TDP2004 is determined by the pin strap settings on the ADDR1 and ADDR0 pins. The sixteen possible secondary addresses for channels 0-3 are provided in 表 6-4. In SMBus/I²C modes the SCL and SDA pins must be pulled up to a 3.3V supply with a pullup resistor. The value of the resistor depends on total bus capacitance. $4.7k\Omega$ is a good first approximation for a bus capacitance of 10pF.

表 6-4. SMBUS/I²C Secondary Address Settings

ADDR1	ADDR0	7-bit Secondary Address Channels 0-3
L0	L0	0x18
L0	L1	0x1A
L0	L2	0x1C
L0	L3	0x1E
L0	L4	Reserved
L1	L0	0x20
L1	L1	0x22
L1	L2	0x24
L1	L3	0x26
L1	L4	Reserved
L2	LO	0x28

Product Folder Links: TDP2004

Copyright © 2024 Texas Instruments Incorporated

資料に関するフィードバック(ご意見やお問い合わせ)を送信

13



表 6-4. SMBUS/I²C Secondary Address Settings (続き)

ADDR1	ADDR0	7-bit Secondary Address Channels 0-3
L2	L1	0x2A
L2	L2	0x2C
L2	L3	0x2E
L2	L4	Reserved
L3	L0	0x30
L3	L1	0x32
L3	L2	0x34
L3	L3	0x36
L3	L4	Reserved

The TDP2004 has two types of registers:

- **Shared Registers:** these registers can be accessed at any time and are used for device-level configuration, status read back, control, or to read back the device ID information.
- Channel Registers: these registers are used to control and configure specific features for each individual channel. All channels have the same register set and can be configured independent of each other or configured as a group through broadcast writes to Channels 0-3.

表 6-5. Channel Register Access

Channel Registers Base Address	Channel 0-3 Access
0x00	Channel 0 registers
0x20	Channel 1 registers
0x40	Channel 2 registers
0x60	Channel 3 registers
0x80	Broadcast write channel 0-3 registers, read channel 0 registers
0xA0	Broadcast write channel 0-1 registers, read channel 0 registers
0xC0	Broadcast write channel 2-3 registers, read channel 2 registers
0xE0	Channel 0-3 share registers

6.5.2.1 Shared Registers

表 6-6. General Registers (Offset = 0xE2)

	5 (0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0					
Bit	Field	Type	Reset	Description		
7	RESERVED	R	0x0	Reserved		
6	rst_i2c_regs	R/W/SC	0x0	Device reset control: Reset all I ² C registers to default values (self-clearing).		
5	rst_i2c_mas	R/W/SC	0x0	Reset I ² C Primary (self-clearing).		
4-1	RESERVED	R	0x0	Reserved		
0	frc_eeprm_rd	R/W/SC	0x0	Override MODE and READ_EN_N status to force manual EEPROM configuration load.		

表 6-7. EEPROM_Status Register (Offset = 0xE3)

	2. 0 11 ==1 1100 111110 110 (0 110 01 01 01 01 01 01 01 01 01 01 01 0						
Bit	Field	Туре	Reset	Description			
7	eecfg_cmplt	R	0x0	EEPROM load complete.			
6	eecfg_fail	R	0x0	EEPROM load failed.			
5	eecfg_atmpt_1	R	0x0	Number of attempts made to load EEPROM image.			
4	eecfg_atmpt_0	R	0x0				
3	eecfg_cmplt	R	0x0	EEPROM load complete 2.			
2	eecfg_fail	R	0x0	EEPROM load failed 2.			

資料に関するフィードバック(ご意見やお問い合わせ)を送信

Copyright © 2024 Texas Instruments Incorporated

English Data Sheet: SNLS745

表 6-7. EEPROM_Status Register (Offset = 0xE3) (続き)

Bit	Field	Туре	Reset	Description
1	eecfg_atmpt_1	R	0x0	Number of attempts made to load EEPROM image 2.
0	eecfg_atmpt_0	R	0x0	

表 6-8. DEVICE_ID0 Register (Offset = 0xF0)

Bit	Field	Туре	Reset	Description
7-4	RESERVED	R	0x0	Reserved
3	device_id0_3	R	0x0	Device ID0 [3:1]: 011
2	device_id0_2	R	0x1	
1	device_id0_1	R	0x1	
0	RESERVED	R	Х	Reserved

表 6-9. DEVICE_ID1 Register (Offset = 0xF1)

Bit	Field	Туре	Reset	Description
7	device_id[7]	R	0x0	Device ID 0010 1001: TDP2004
6	device_id[6]	R	0x0	
5	device_id[5]	R	0x1	
4	device_id[4]	R	0x0	
3	device_id[3]	R	0x1	
2	device_id[2]	R	0x0	
1	device_id[1]	R	0x0	
0	device_id[0]	R	0x0	

6.5.2.2 Channel Registers

表 6-10. EQ Gain Control Register (Channel register base + Offset = 0x01)

Bit	Field	Туре	Reset	Description
7	eq_stage1_bypass	R/W	0x0	Enable EQ stage 1 bypass:
				0: Bypass disabled
				1: Bypass enabled
6	eq_stage1_3	R/W	0x0	EQBoost stage 1 control
5	eq_stage1_2	R/W	0x0	See 表 6-1 for details
4	eq_stage1_1	R/W	0x0	
3	eq_stage1_0	R/W	0x0	
2	eq_stage2_2	R/W	0x0	EQ Boost stage 2 control
1	eq_stage2_1	R/W	0x0	See 表 6-1 for details
0	eq_stage2_0	R/W	0x0	

表 6-11. EQ Gain / Flat Gain Control Register (Channel register base + Offset = 0x03)

Bit	Field	Type	Reset	Description
7	RESERVED	R	0x0	Reserved
6	eq_profile_3	R/W	0x0	EQ mid-frequency boost profile
5	eq_profile_2	R/W	0x0	See 表 6-1 for details
4	eq_profile_1	R/W	0x0	
3	eq_profile_0	R/W	0x0	

Copyright © 2024 Texas Instruments Incorporated

資料に関するフィードバック(ご意見やお問い合わせ)を送信

15



表 6-11. EQ Gain / Flat Gain Control Register (Channel register base + Offset = 0x03) (続き)

Bit	Field	Туре	Reset	Description
2	flat_gain_2	R/W	0x1	Flat gain select:
1	flat_gain_1	R/W	0x0	See 表 6-2 for details
0	flat_gain_0	R/W	0x1	

表 6-12. TI Test Mode Control Register (Channel register base + Offset = 0x04)

Bit	Field	Туре	Reset	Description			
7-3, 1-0	RESERVED	R	0x0	Reserved			
2	TI test mode	R/W	0x0 Set TI test mode:				
				0: test mode is enabled			
				1: test mode is disabled. Must be set to "1" for normal operation			

表 6-13. PD Override Register (Channel register base + Offset = 0x05)

Bit	Field	Туре	Reset	Description
7	device_en_override	R/W	0x0	Enable power down overrides through SMBus/l ² C 0: Manual override disabled 1: Manual override enabled
6-0	device_en	R/W	0x111111	Manual power down of redriver various blocks of a channel – gated by device_en_override = 1 111111: All blocks in the channel are enabled 000000: All blocks in the channel are disabled

表 6-14. Bias Register (Channel register base + Offset = 0x06)

Bit	Field	Туре	Reset	Description		
5-3	Bias current	R/W		Control bias current Set 001 for best performance		
7,6,2-0	Reserved	R/W	0x00000	Reserved		

6.5.3 SMBus/I²C Primary Mode Configuration (EEPROM Self Load)

The TDP2004 can also be configured by reading from EEPROM. To enter into this mode MODE pin must be set to L1. The EEPROM load operation only happens once after the initial powerup of the device. If the TDP2004 is configured for SMBus Primary mode, the device remains in the SMBus IDLE state until the READ_EN_N pin is asserted to LOW. After the READ_EN_N pin is driven LOW, theTDP2004 becomes an SMBus primary and attempts to self-configure by reading the device settings stored in an external EEPROM (SMBus 8-bit address 0xA0). When the TDP2004 has finished reading from the EEPROM successfully, the device drives the DONEn pin LOW. SMBus/I²C secondary operation is available in this mode before, during, or after EEPROM reading. Note: during EEPROM reading, if the external SMBus/I²C primary wants to access TDP2004 registers, the external controller must support arbitration.

When designing a system for using the external EEPROM, the user must follow these specific guidelines:

- EEPROM size of 2Kb (256 × 8-bit) is recommended.
- Set MODE = L1, configure for SMBus Primary mode.

資料に関するフィードバック(ご意見やお問い合わせ)を送信

- The external EEPROM device address byte must be 0xA0 and capable of 400kHz operation at 3.3V supply
- In SMBus/I²C modes the SCL and SDA pins must be pulled up to a 3.3V supply with a pullup resistor. The value of the resistor depends on total bus capacitance. 4.7kΩ is a good first approximation for a bus capacitance of 10pF.

Multiple TDP2004 can be cascaded to read from single EEPROM. Tie the READ_EN_N pin of the first device low (GND) to automatically initiate EEPROM read at power up. DONEn of the first device can be fed into READ_EN_N of the next device with $4.7k\Omega$ pullup resistors. Leave the DONEn pin of the final device floating, or connect the pin to a microcontroller input to monitor the completion of the final EEPROM read.

Product Folder Links: TDP2004

7 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Application Information

The TDP2004 is a high-speed linear repeater which extends the reach of differential channels impaired by loss from transmission media like PCBs and cables. The device can be deployed in a variety of different systems. The following sections outline typical applications and their associated design considerations.

7.2 Typical Applications

The TDP2004 is a linear redriver that can be used as DisplayPort mainlink signal conditioner. The TDP2004 can be used in both source and sink applications as illustrated in \boxtimes 7-1. The device also supports DP++ signaling while used for DisplayPort mode.

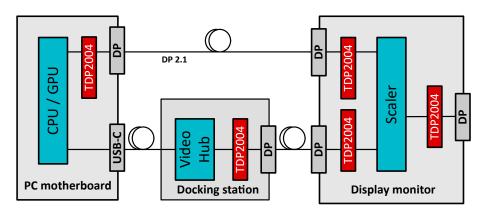


図 7-1. Typical Application

7.2.1 DP 2.1 Mainlink Signal Conditioning

The TDP2004 can be used in a video source/sink systems such as PC motherboard, industrial PCs, docking stations, industrial display/signs, display monitor among other applications to boost DisplayPort mainlink signals to increase the reach of the source and sink channel. The following sections outline detailed procedures and design requirements for a typical DP 2.1 application. However, the design recommendations can be used in other use cases.

7.2.1.1 Design Requirements

As with any high-speed design, there are many factors which influence the overall performance. The following list indicates critical areas for consideration during design.

- Match the length between the P and N traces of the single-end segments of the differential pair.
- Use a uniform trace width and trace spacing for differential pairs.
- Place AC-coupling capacitors near the receiver end of each channel segment to minimize reflections.
- AC-coupling capacitors of 220nF are recommended. Set the maximum body size to 0402 and add a cutout void on the GND plane below the landing pad of the capacitor to reduce parasitic capacitance to GND.
- Surface mount connector is recommended. For through hole connection, back-drill connector vias and signal vias to minimize stub length.

Copyright © 2024 Texas Instruments Incorporated

資料に関するフィードバック(ご意見やお問い合わせ)を送信

17



Use ground reference plane vias for a low inductance path for the return current.

7.2.1.2 Detailed Design Procedure

The TDP2004 provides signal conditioning for four DP mainlink channels. The device is a linear redriver which is agnostic to DP link training. The DP link training negotiation between a display source and sink stays effective through the device. The redriver becomes part of the electrical channel along with passive traces, cables, and other channel elements, resulting in optimum source and sink parameters for best electrical link. \boxtimes 7-2 shows a simplified schematic for DisplayPort application using TDP2004.

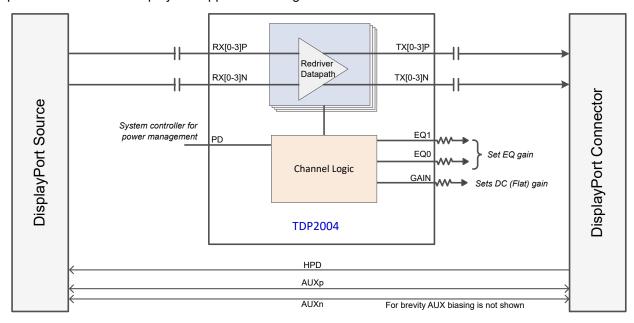


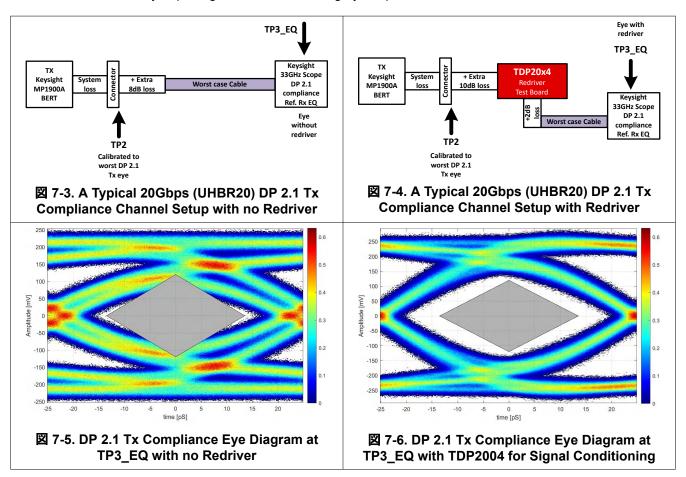
図 7-2. Simplified Schematic for DP 2.1 Signal Conditioning in a Source Application such as PC Motherboard in Pin Mode

A sink implementation is similar for DP alternate mode configurations C and D.

閉い合わせ) を送信 Copyright © 2024 Texas Instruments Incorporated Product Folder Links: *TDP2004*

7.2.1.3 Application Curves

The TDP2004 is a linear redriver that can be used to extend channel reach of a DP link. The redriver can help to pass compliance by removing ISI deterministic jitter at data rates up to 20Gbps (UHBR20). \boxtimes 7-3 - \boxtimes 7-6 shows a typical DP 2.1 Tx compliance channel setup along with compliance Eye Diagrams at TP3_EQ with or without redriver. The comparison of eye diagrams show that TDP2004 can provide signal conditioning by extending horizontal and vertical eye openings that makes a failing eye to pass.



7.3 Power Supply Recommendations

Follow these general guidelines when designing the power supply:

- 1. The power supply must be designed to provide the operating conditions outlined in the recommended operating conditions section in terms of DC voltage, AC noise, and start-up ramp time.
- 2. The TDP2004 does not require any special power supply filtering, such as ferrite beads, provided that the recommended operating conditions are met. Only standard supply decoupling is required. Typical supply decoupling consists of a 0.1μF capacitor per VCC pin, one 1.0μF bulk capacitor per device, and one 10μF bulk capacitor per power bus that delivers power to one or more TDP2004 devices. The local decoupling (0.1μF) capacitors must be connected as close to the VCC pins as possible and with minimal path to the TDP2004 ground pad.

English Data Sheet: SNLS745



7.4 Layout

7.4.1 Layout Guidelines

Refere to following guidelines when designing the layout of the system implementation:

- 1. Place the decoupling capacitors as close to the VCC pins as possible. Placing the decoupling capacitors directly underneath the device is recommended if the board design permits.
- 2. Make sure the high-speed differential signals TXnP/TXnN and RXnP/RXnN are tightly coupled, skew matched, and impedance controlled.
- 3. Avoid vias when possible on the high-speed differential signals. When vias must be used, take care to minimize the via stub, either by transitioning through most or all layers or by back drilling.
- 4. GND relief can be used (but is not required) beneath the high-speed differential signal pads to improve signal integrity by counteracting the pad capacitance.
- 5. Place GND vias directly beneath the device connecting the GND plane attached to the device to the GND planes on other layers. This has the added benefit of improving thermal conductivity from the device to the board.
- 6. Refer to land pattern example in the mechanical drawing section for the device thermal pad design recommendation.

7.4.2 Layout Example



図 7-7. TDP2004 Layout Example – Sub-Section of TI Evaluation Board with DP Connectors

Product Folder Links: TDP2004

資料に関するフィードバック(ご意見やお問い合わせ) を送信

Copyright © 2024 Texas Instruments Incorporated

8 Device and Documentation Support

8.1 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jp のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。 変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

8.2 サポート・リソース

テキサス・インスツルメンツ E2E™ サポート・フォーラムは、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計で必要な支援を迅速に得ることができます。

リンクされているコンテンツは、各寄稿者により「現状のまま」提供されるものです。これらはテキサス・インスツルメンツの仕様を構成するものではなく、必ずしもテキサス・インスツルメンツの見解を反映したものではありません。テキサス・インスツルメンツの使用条件を参照してください。

8.3 Trademarks

テキサス・インスツルメンツ E2E™ is a trademark of Texas Instruments. すべての商標は、それぞれの所有者に帰属します。

8.4 静電気放電に関する注意事項



この IC は、ESD によって破損する可能性があります。テキサス・インスツルメンツは、IC を取り扱う際には常に適切な注意を払うことを推奨します。正しい取り扱いおよび設置手順に従わない場合、デバイスを破損するおそれがあります。

ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

8.5 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

9 Revision History

Changes from Revision * (November 2023) to Revision A (April 2024)

Page

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Copyright © 2024 Texas Instruments Incorporated

資料に関するフィードバック(ご意見やお問い合わせ)を送信

21

重要なお知らせと免責事項

テキサス・インスツルメンツは、技術データと信頼性データ (データシートを含みます)、設計リソース (リファレンス デザインを含みます)、アプリケーションや設計に関する各種アドバイス、Web ツール、安全性情報、その他のリソースを、欠陥が存在する可能性のある「現状のまま」提供しており、商品性および特定目的に対する適合性の黙示保証、第三者の知的財産権の非侵害保証を含むいかなる保証も、明示的または黙示的にかかわらず拒否します。

これらのリソースは、テキサス・インスツルメンツ製品を使用する設計の経験を積んだ開発者への提供を意図したものです。(1) お客様のアプリケーションに適した テキサス・インスツルメンツ製品の選定、(2) お客様のアプリケーションの設計、検証、試験、(3) お客様のアプリケーションに該当する各種規格や、その他のあらゆる安全性、セキュリティ、規制、または他の要件への確実な適合に関する責任を、お客様のみが単独で負うものとします。

上記の各種リソースは、予告なく変更される可能性があります。これらのリソースは、リソースで説明されているテキサス・インスツルメンツ製品を使用するアプリケーションの開発の目的でのみ、テキサス・インスツルメンツはその使用をお客様に許諾します。これらのリソースに関して、他の目的で複製することや掲載することは禁止されています。テキサス・インスツルメンツや第三者の知的財産権のライセンスが付与されている訳ではありません。お客様は、これらのリソースを自身で使用した結果発生するあらゆる申し立て、損害、費用、損失、責任について、テキサス・インスツルメンツおよびその代理人を完全に補償するものとし、テキサス・インスツルメンツは一切の責任を拒否します。

テキサス・インスツルメンツの製品は、テキサス・インスツルメンツの販売条件、または ti.com やかかる テキサス・インスツルメンツ製品の関連資料などのいずれかを通じて提供する適用可能な条項の下で提供されています。テキサス・インスツルメンツがこれらのリソースを提供することは、適用されるテキサス・インスツルメンツの保証または他の保証の放棄の拡大や変更を意味するものではありません。

お客様がいかなる追加条項または代替条項を提案した場合でも、テキサス・インスツルメンツはそれらに異議を唱え、拒否します。

郵送先住所: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated www.ti.com 10-Apr-2024

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
TDP2004IRNQR	ACTIVE	WQFN	RNQ	40	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TDP2	Samples
TDP2004IRNQT	ACTIVE	WQFN	RNQ	40	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TDP2	Samples
TDP2004RNQR	ACTIVE	WQFN	RNQ	40	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	TDP2	Samples
TDP2004RNQT	ACTIVE	WQFN	RNQ	40	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	TDP2	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and



PACKAGE OPTION ADDENDUM

www.ti.com 10-Apr-2024

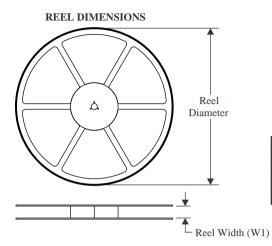
continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 10-Apr-2024

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TDP2004IRNQR	WQFN	RNQ	40	3000	330.0	12.4	4.3	6.3	1.1	8.0	12.0	Q2
TDP2004IRNQT	WQFN	RNQ	40	250	180.0	12.4	4.3	6.3	1.1	8.0	12.0	Q2
TDP2004RNQR	WQFN	RNQ	40	3000	330.0	12.4	4.3	6.3	1.1	8.0	12.0	Q2
TDP2004RNQT	WQFN	RNQ	40	250	180.0	12.4	4.3	6.3	1.1	8.0	12.0	Q2



www.ti.com 10-Apr-2024

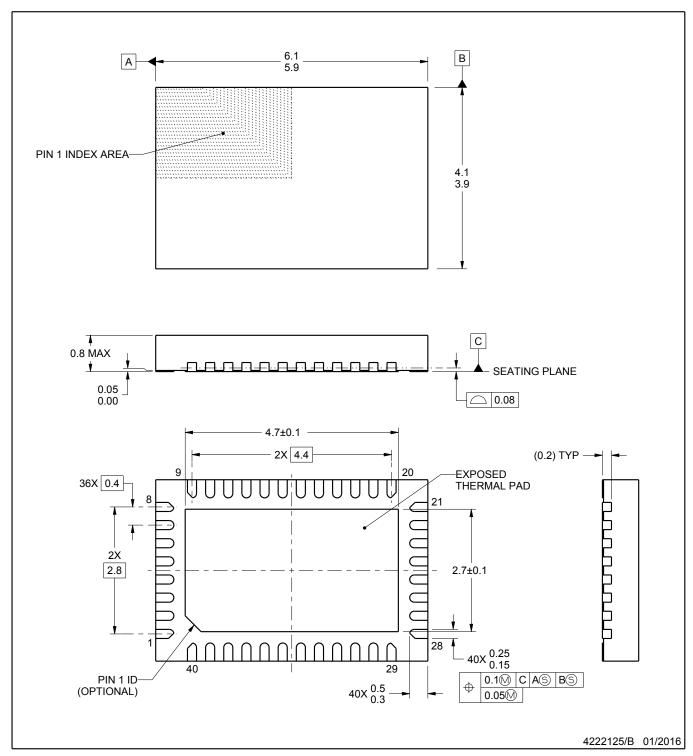


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TDP2004IRNQR	WQFN	RNQ	40	3000	367.0	367.0	35.0
TDP2004IRNQT	WQFN	RNQ	40	250	210.0	185.0	35.0
TDP2004RNQR	WQFN	RNQ	40	3000	367.0	367.0	35.0
TDP2004RNQT	WQFN	RNQ	40	250	210.0	185.0	35.0



PLASTIC QUAD FLATPACK - NO LEAD

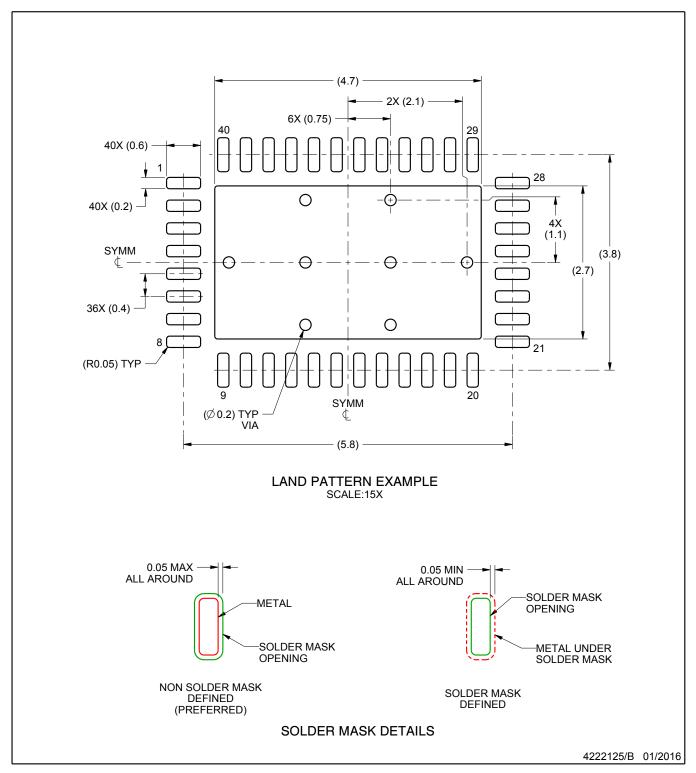


NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC QUAD FLATPACK - NO LEAD

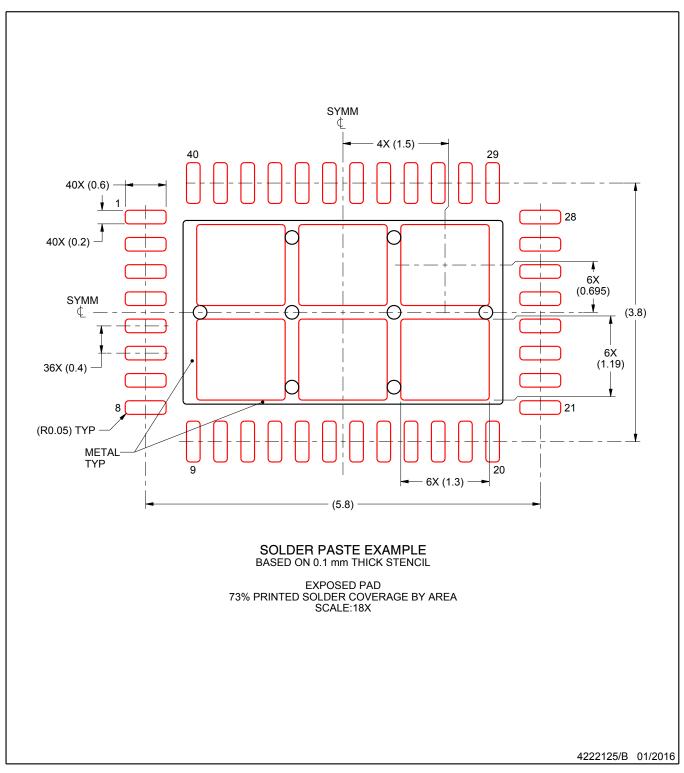


NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



重要なお知らせと免責事項

TI は、技術データと信頼性データ (データシートを含みます)、設計リソース (リファレンス・デザインを含みます)、アプリケーションや設計に関する各種アドバイス、Web ツール、安全性情報、その他のリソースを、欠陥が存在する可能性のある「現状のまま」提供しており、商品性および特定目的に対する適合性の黙示保証、第三者の知的財産権の非侵害保証を含むいかなる保証も、明示的または黙示的にかかわらず拒否します。

これらのリソースは、TI 製品を使用する設計の経験を積んだ開発者への提供を意図したものです。(1) お客様のアプリケーションに適した TI 製品の選定、(2) お客様のアプリケーションの設計、検証、試験、(3) お客様のアプリケーションに該当する各種規格や、その他のあら ゆる安全性、セキュリティ、規制、または他の要件への確実な適合に関する責任を、お客様のみが単独で負うものとします。

上記の各種リソースは、予告なく変更される可能性があります。これらのリソースは、リソースで説明されている TI 製品を使用するアプリケーションの開発の目的でのみ、TI はその使用をお客様に許諾します。これらのリソースに関して、他の目的で複製することや掲載することは禁止されています。TI や第三者の知的財産権のライセンスが付与されている訳ではありません。お客様は、これらのリソースを自身で使用した結果発生するあらゆる申し立て、損害、費用、損失、責任について、TI およびその代理人を完全に補償するものとし、TI は一切の責任を拒否します。

TIの製品は、TIの販売条件、または ti.com やかかる TI 製品の関連資料などのいずれかを通じて提供する適用可能な条項の下で提供されています。TI がこれらのリソースを提供することは、適用される TI の保証または他の保証の放棄の拡大や変更を意味するものではありません。

お客様がいかなる追加条項または代替条項を提案した場合でも、TIはそれらに異議を唱え、拒否します。

郵送先住所: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated